

UNISONIC TECHNOLOGIES CO., LTD

12N60K-MT Power MOSFET

12A, 600V N-CHANNEL POWER MOSFET

DESCRIPTION

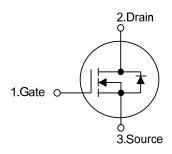
The UTC **12N60K-MT** are N-Channel enhancement mode power field effect transistors (MOSFET) which are produced using UTC's proprietary, planar stripe, DMOS technology.

These devices are suited for high efficiency switch mode power supply. To minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode the advanced technology has been especially tailored.

■ FEATURES

- * $R_{DS(ON)}$ < 0.70 Ω @ V_{GS} = 10 V, I_D = 6 A
- * Fast switching capability
- * Avalanche energy specified
- * Improved dv/dt capability, high ruggedness

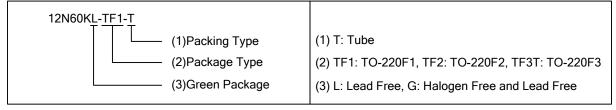
■ SYMBOL



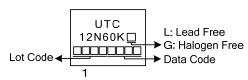
ORDERING INFORMATION

Ordering Number		Dookogo	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
12N60KL-TF1-T	12N60KG-TF1-T	TO-220F1	G	D	S	Tube	
12N60KL-TF2-T	12N60KG-TF2-T	TO-220F2	G	D	S	Tube	
12N60KL-TF3T-T	12N60KG-TF3T-T	TO-220F3	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



MARKING



TO-220F1

TO-220F2

TO-220F3

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■ ABSOLUTE MAXIMUM RATINGS (T_C = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain-Source Voltage		V_{DSS}	600	V	
Gate-Source Voltage		V_{GSS}	±30	V	
Drain Current	Continuous	I_{D}	12	Α	
	Pulsed (Note 2)	I_{DM}	48	Α	
Avalanche Energy	che Energy Single Pulsed (Note 3)		420	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	4.5	V/ns	
Power Dissipation		P_{D}	51	W	
Junction Temperature		T_J	+150	°C	
Operating Temperature		T_{OPR}	-55 ~ + 150	°C	
Storage Temperature		T _{STG}	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating : Pulse width limited by maximum junction temperature
- 3. L = 5.8mH, I_{AS} = 12A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}$ C
- 4. $I_{SD} \le 12A$, di/dt $\le 200A/s$, $V_{DD} \le BV_{DSS}$ Starting $T_J = 25$ °C

■ THERMAL DATA

PARAMETER	SYMBOL	RATING	UNIT	
Junction to Ambient	θ_{JA}	62.5	°C/W	
Junction to Case	θ _{JC}	2.43	°C/W	

■ ELECTRICAL CHARACTERISTICS (T_C =25°C, unless otherwise specified)

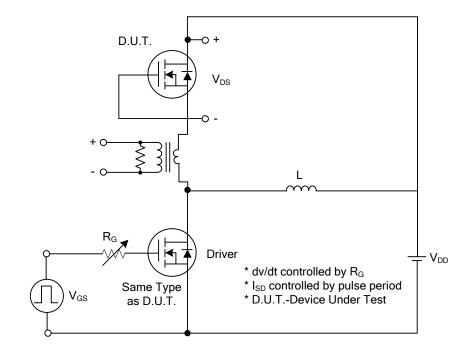
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage	BV _{DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	600			V		
Drain-Source Leakage Current	I _{DSS}	V _{DS} = 600 V, V _{GS} = 0 V			1	μΑ		
Gate-Source Leakage Current	I _{GSS}	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA		
Breakdown Voltage Temperature Coefficient	$\triangle BV_{DSS}/\triangle T_{J}$	I _D =250μA, Referenced to 25°C		0.7		V/°C		
ON CHARACTERISTICS								
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	2.0		4.0	V		
Static Drain-Source On-State Resistance	R _{DS(ON)}	$V_{GS} = 10V, I_D = 6.0A$		0.57	0.70	Ω		
DYNAMIC CHARACTERISTICS								
Input Capacitance	C _{ISS}	-V _{DS} = 25 V, V _{GS} = 0 V, -f = 1MHz		1600	1900	pF		
Output Capacitance	Coss			173	270	pF		
Reverse Transfer Capacitance	C _{RSS}			10	18	pF		
SWITCHING CHARACTERISTICS								
Turn-On Delay Time	t _{D(ON)}			90	100	ns		
Turn-On Rise Time	t _R	$V_{DD} = 30V, I_D = 0.5A,$ $R_G = 25\Omega \text{ (Note 1, 2)}$		109	125	ns		
Turn-Off Delay Time	t _{D(OFF)}			190	210	ns		
Turn-Off Fall Time	t_{F}			100	130	ns		
Total Gate Charge	Q_G	-V _{DS} = 50V,I _D = 1.3A, -V _{GS} = 10 V (Note 1, 2)		40		nC		
Gate-Source Charge	Q_GS			10.4		nC		
Gate-Drain Charge	Q_GD			10		nC		
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS								
Drain-Source Diode Forward Voltage	V_{SD}	$V_{GS} = 0 \text{ V}, I_{S} = 12\text{A}$			1.4	V		
Maximum Continuous Drain-Source Diode	I.				12	Α		
Forward Current	I _S				12	А		
Maximum Pulsed Drain-Source Diode	la				48	Α		
Forward Current	I _{SM}				40	А		

Notes: 1. Pulse Test : Pulse width ≤300µs, Duty cycle ≤ 2%.

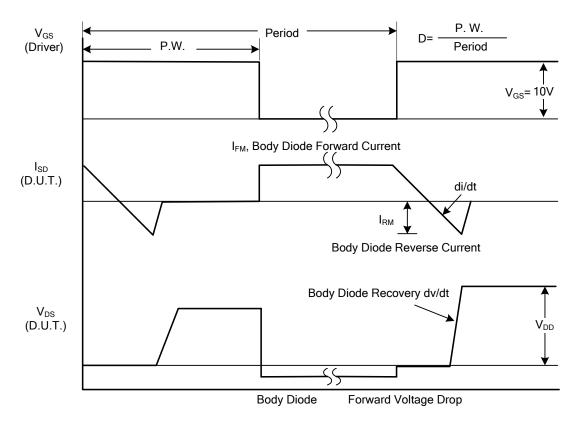
2. Essentially independent of operating temperature.



■ TEST CIRCUITS AND WAVEFORMS



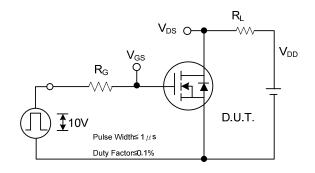
Peak Diode Recovery dv/dt Test Circuit



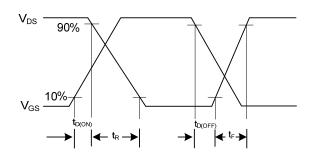
Peak Diode Recovery dv/dt Waveforms

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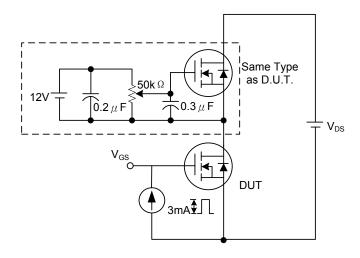
■ TEST CIRCUITS AND WAVEFORMS (Cont.)



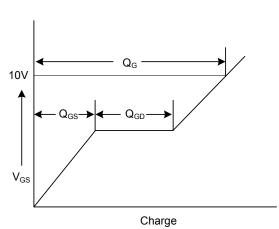
Switching Test Circuit



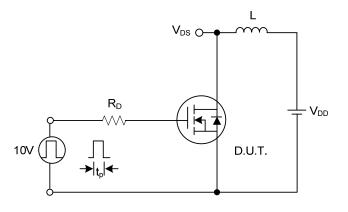
Switching Waveforms



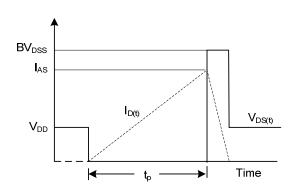
Gate Charge Test Circuit



Gate Charge Waveform



Unclamped Inductive Switching Test Circuit



Unclamped Inductive Switching Waveforms

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